

Notice of References Cited	Application/Control No. 10/005,140	Applicant(s)/Patent Under Reexamination KLIEWE, JOHN	
	Examiner Jason Mitchell	Art Unit 2124	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,189,010 B1	02-2001	Isip, Jr., Amando B.	707/100
	B	US-6,615,222 B2	09-2003	Hornibrook et al.	707/200
	C	US-6,505,212 B2	01-2003	Nakano et al.	707/200
	D	US-6,460,041 B2	10-2002	Lloyd, Steven D.	707/10
	E	US-2003/0028555 A1	02-2003	Young et al.	707/204
	F	US-6,446,089 B1	09-2002	Brodersen et al.	707/201
	G	US-5,561,763 A	10-1996	Eto et al.	714/35
	H	US-5,577,198 A	11-1996	Willrett et al.	714/33
	I	US-2002/0178174 A1	11-2002	Wakabayashi, Ryuji	707/200
	J	US-4,688,222	08-1987	Blum, Arnold	714/732
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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